

CoolMOS® Power Transistor

Features

- Worldwide best $R_{
 m ds,on}$ in TO247
- · Ultra low gate charge
- Extreme dv/dt rated
- · High peak current capability
- Qualified for industrial grade applications according to JEDEC¹⁾
- Pb-free lead plating; RoHS compliant

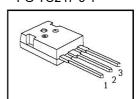
CoolMOS CP is specially designed for:

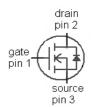
• Hard switching SMPS topologies

Product Summary

V _{DS} @ T _{jmax}	650	٧
R _{DS(on),max}	0.045	Ω
Q _{g,typ}	150	nC







Туре	Package	Ordering Code	Marking
IPW60R045CP	PG-TO247-3-1	SP000067149	6R045

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C	60	А
		T _C =100 °C	38	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	230	
Avalanche energy, single pulse	E _{AS}	/ _D =11 A, V _{DD} =50 V	1950	mJ
Avalanche energy, repetitive $t_{AR}^{(2),3)}$	E _{AR}	/ _D =11 A, V _{DD} =50 V	3	
Avalanche current, repetitive $t_{AR}^{(2),3)}$	I _{AR}		11	А
MOSFET dv/dt ruggedness	dv/dt	V _{DS} =0480 V	50	V/ns
Gate source voltage	V _{GS}	static	±20	V
		AC (f>1 Hz)	±30	
Power dissipation	P _{tot}	T _C =25 °C	431	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
Mounting torque		M3 and M3.5 screws	60	Ncm

Unit

Values



Parameter

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous diode forward current / _S		Т _С =25 °С	44	А
Diode pulse current ²⁾	I _{S,pulse}	7 _C -23 G	230	
Reverse diode dv/dt ⁴⁾	d <i>v l</i> dt		15	V/ns

			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R _{thJC}		-	-	0.29	K/W
Thermal resistance, junction - ambient	$R_{ m thJA}$	leaded	ı	1	62	
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	-	-	260	°C

Symbol Conditions

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =250 μA	600	-	-	V
Gate threshold voltage	V _{GS(th)}	$V_{\rm DS} = V_{\rm GS}$, $I_{\rm D} = 3$ mA	2.5	3	3.5	
Zero gate voltage drain current	I _{DSS}	V _{DS} =600 V, V _{GS} =0 V, T _j =25 °C	1	1	10	μA
		V _{DS} =600 V, V _{GS} =0 V, T _j =150 °C	1	50	-	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	1	100	nA
Drain-source on-state resistance R _{DS(or}		V _{GS} =10 V, I _D =44 A, T _j =25 °C	1	0.04	0.045	Ω
		V _{GS} =10 V, I _D =44 A, T _j =150 °C	-	0.11	-	
Gate resistance	R _G	f=1 MHz, open drain	-	1.3	-	Ω



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss	V _{GS} =0 V, V _{DS} =100 V,	-	6800	-	pF
Output capacitance	C oss	f=1 MHz	ı	320	1	
Effective output capacitance, energy related ⁵⁾	C _{o(er)}	V _{GS} =0 V, V _{DS} =0 V	-	310	-	
Effective output capacitance, time related ⁶⁾	C _{o(tr)}	to 480 V	-	820	-	
Turn-on delay time	t _{d(on)}		-	30	-	ns
Rise time	t _r	V _{DD} =400 V, V _{GS} =10 V, I _D =44 A,	-	20	-	
Turn-off delay time	$t_{d(off)}$	$R_{\rm G}$ =3.3 Ω	-	100	-	
Fall time	t _f		-	10	-	
Gate Charge Characteristics						
Gate to source charge	Q _{gs}		-	34	-	nC
Gate to drain charge	Q_{gd}	V _{DD} =400 V, I _D =44 A,	-	51	-	
Gate charge total	Qg	V _{GS} =0 to 10 V	-	150	190	
Gate plateau voltage	V _{plateau}]	-	5.0	-	V
Reverse Diode						
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =44 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time	t _{rr}		-	600	-	ns
Reverse recovery charge	Qrr	V _R =400 V, I _F =I _S , di _F /dt=100 A/μs	-	17	-	μC
Peak reverse recovery current	/ _{rrm}		-	60	-	А

¹⁾ J-STD20 and JESD22

²⁾ Pulse width t_p limited by $T_{i,max}$

 $^{^{3)}}$ Repetitive avalanche causes additional power losses that can be calculated as $P_{\rm AV}$ = $E_{\rm AR}$ * $f_{\rm AV}$

 $^{^{4)}} I_{\text{SD}} \leq I_{\text{D}}, \text{ d}iI\text{d}t \leq 100\text{A/}\mu\text{s}, \text{V}_{\text{DClink}} = 400\text{V}, \text{ V peak} < V_{\text{(BR)DSS}}, \text{ } T_{\text{j}} < T_{\text{jmax}}, \text{ identical low side and high side switch}$

 $^{^{5)}}$ $C_{\rm o(er)}$ is a fixed capacitance that gives the same stored energy as $C_{\rm oss}$ while $V_{\rm DS}$ is rising from 0 to 80% $V_{\rm DSS}$.

 $^{^{6)}}$ C $_{o(tr)}$ is a fixed capacitance that gives the same charging time as C $_{oss}$ while V_{DS} is rising from 0 to 80% V_{DSS} .



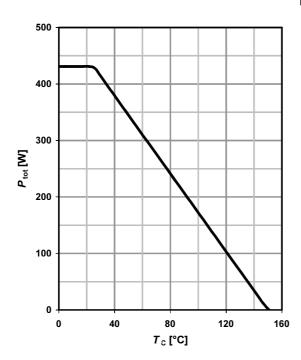
1 Power dissipation

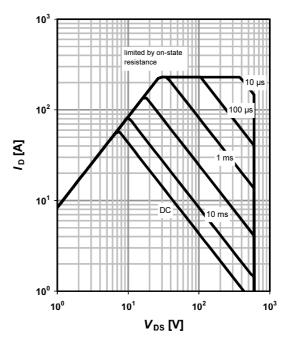
P_{tot} =f(T_{C})

2 Safe operating area

$$I_D$$
=f(V_{DS}); T_C =25 °C; D =0

parameter: t_p





3 Max. transient thermal impedance

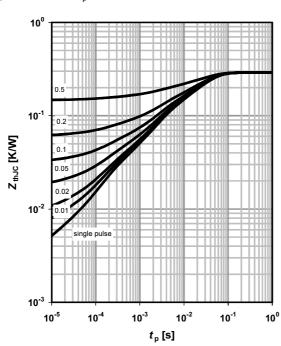
 $Z_{(thJC)}$ = $f(t_p)$

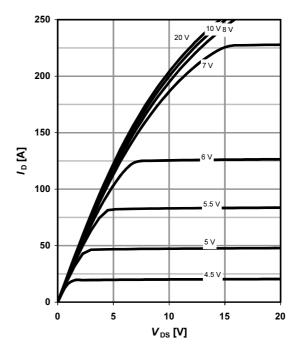
parameter: D=t_p/T

4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C$

parameter: V_{GS}



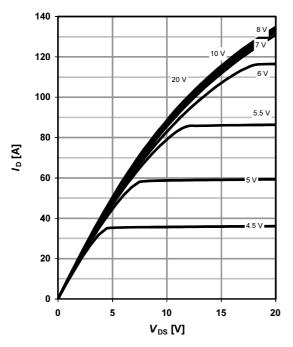




5 Typ. output characteristics

 $I_{D} = f(V_{DS}); T_{j} = 150 \text{ °C}$

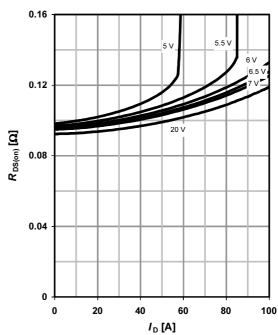
parameter: V_{GS}



6 Typ. drain-source on-state resistance

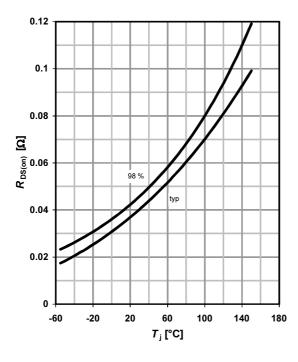
 $R_{DS(on)}=f(I_D); T_j=150 °C$

parameter: V_{GS}



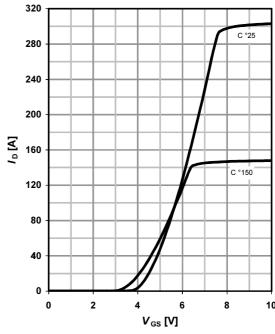
7 Drain-source on-state resistance

 $R_{DS(on)}$ =f(T_i); I_D =44 A; V_{GS} =10 V



8 Typ. transfer characteristics

 $I_{\rm D}$ =f($V_{\rm GS}$); $|V_{\rm DS}|$ >2 $|I_{\rm D}|R_{\rm DS(on)max}$ parameter: $T_{\rm j}$

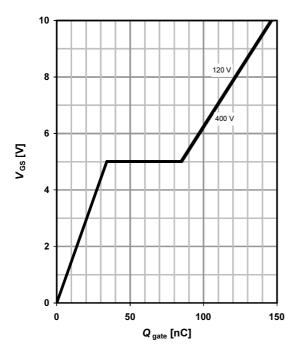




9 Typ. gate charge

V_{GS} =f(Q_{gate}); I_D =44 A pulsed

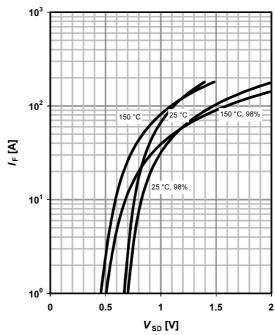
parameter: $V_{\rm DD}$



10 Forward characteristics of reverse diode

 $I_F = f(V_{SD})$

parameter: T_j

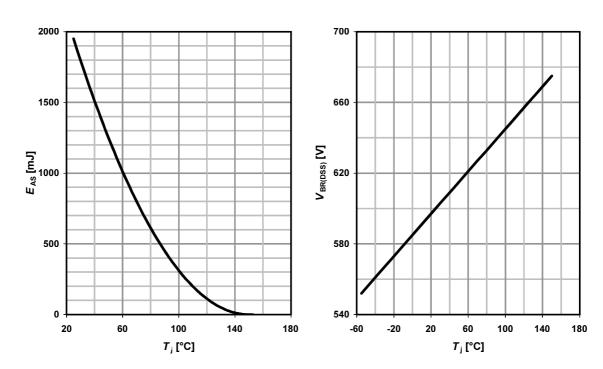


11 Avalanche energy

$$E_{AS}$$
=f(T_i); I_D =11 A; V_{DD} =50 V

12 Drain-source breakdown voltage

 $V_{BR(DSS)}$ = $f(T_j)$; I_D =0.25 mA



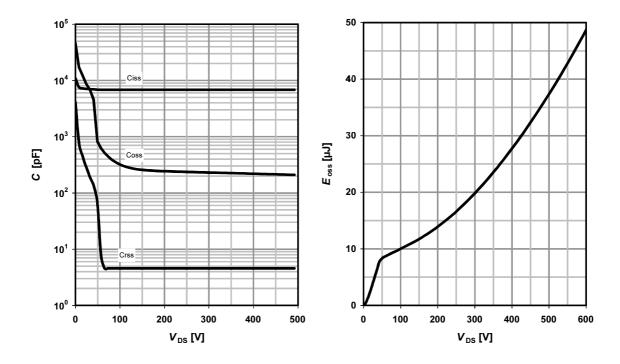


13 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$

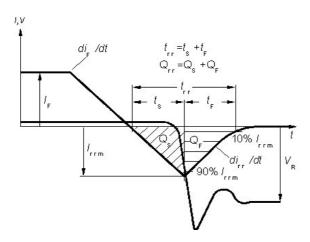
14 Typ. Coss stored energy

$$E_{oss} = f(V_{DS})$$

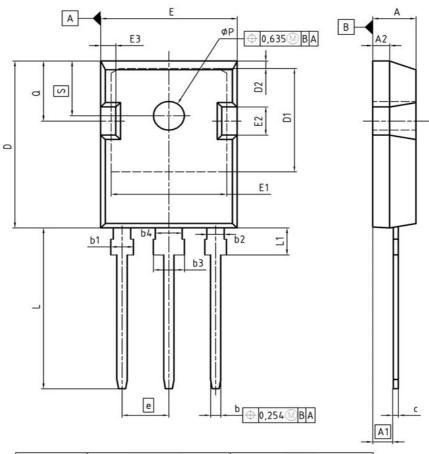




Definition of diode switching characteristics



PG-TO-247-3: Outlines



DIM	MILLIM	ETERS	INCH	HES
DIM	MIN	MAX	MIN	MAX
Α	4.90	5.16	0.193	0.203
A1	2.27	2.53	0.089	0.099
A2	1.85	2.11	0.073	0.083
Ь	1.07	1.33	0.042	0.052
ь1	1.90	2.41	0.075	0.095
b2	1.90	2.16	0.075	0.085
b3	2.87	3.38	0.113	0.133
b4	2.87	3.13	0.113	0.123
С	0.55	0.68	0.022	0.027
D	20.82	21.10	0.820	0.831
D1	16.25	17.65	0.640	0.695
D2	1.05	1.35	0.041	0.053
E	15.70	16.03	0.618	0.631
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.68	2.60	0.066	0.102
е	5.	44	0.2	214
N	1 1	3		3
L	19.80	20.31	0.780	0.799
L1	4.17	4.47	0.164	0.176
øΡ	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248

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SCALE	0
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New package outlines TO-247

1 New package outlines TO-247

Assembly capacity extension for CoolMOSTM technology products assembled in lead-free package PG-TO247-3 at subcontractor ASE (Weihai) Inc., China (Changes are marked in blue.)

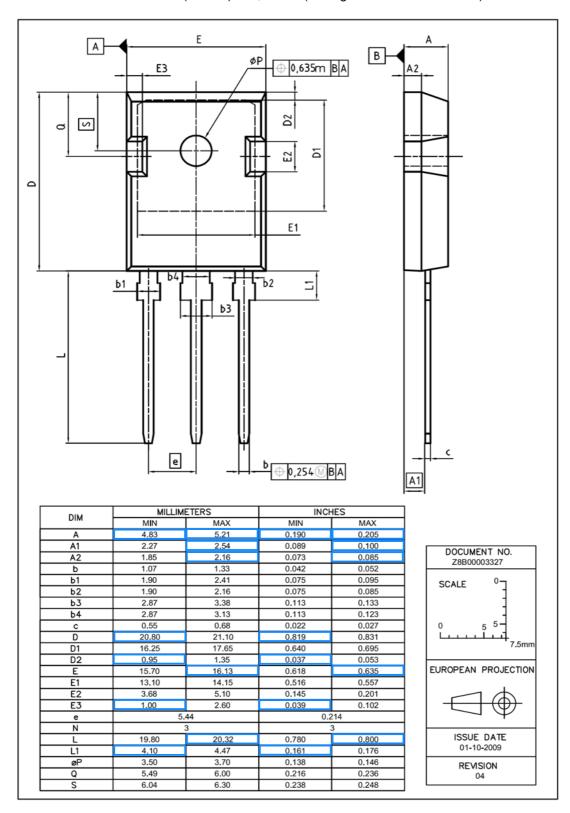


Figure 1 Outlines TO-247, dimensions in mm/inches

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